

# FDP16N50 / FDPF16N50

## 500V N-Channel MOSFET

### Features

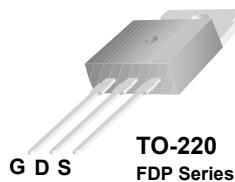
- 16A, 500V,  $R_{DS(on)} = 0.38\Omega$  @  $V_{GS} = 10\text{ V}$
- Low gate charge ( typical 32 nC)
- Low  $C_{rss}$  ( typical 20 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



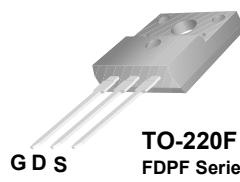
### Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

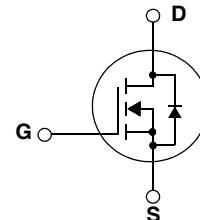
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



TO-220  
FDP Series



TO-220F  
FDPF Series



### Absolute Maximum Ratings

Symbol	Parameter	FDP16N50	FDPF16N50	Unit
$V_{DSS}$	Drain-Source Voltage	500		V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ ) - Continuous ( $T_C = 100^\circ\text{C}$ )	16 9.6	16 * 9.6 *	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	64	A
$V_{GSS}$	Gate-Source voltage		$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy	(Note 2)	780	mJ
$I_{AR}$	Avalanche Current	(Note 1)	16	A
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	20	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ ) - Derate above $25^\circ\text{C}$	200 1.59	38.5 0.3	W W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature

### Thermal Characteristics

Symbol	Parameter	FDP16N50	FDPF16N50	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.63	3.3	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ\text{C}/\text{W}$

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP16N50	FDP16N50	TO-220	-	-	50
FDPF16N50	FDPF16N50	TO-220F	-	-	50

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

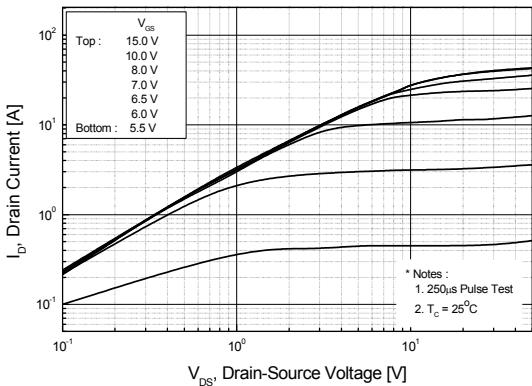
Symbol	Parameter	Conditions	Min.	Typ.	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$	500	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.5	--	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 500\text{V}$ , $V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 400\text{V}$ , $T_C = 125^\circ\text{C}$	-- --	-- --	1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30\text{V}$ , $V_{\text{DS}} = 0\text{V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30\text{V}$ , $V_{\text{DS}} = 0\text{V}$	--	--	-100	nA
<b>On Characteristics</b>						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$	3.0	--	5.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10\text{V}$ , $I_D = 8\text{A}$	--	0.31	0.38	$\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}} = 40\text{V}$ , $I_D = 8\text{A}$	(Note 4)	--	23	S
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $f = 1.0\text{MHz}$	--	1495	1945	pF
$C_{\text{oss}}$	Output Capacitance		--	235	310	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	20	30	pF
<b>Switching Characteristics</b>						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 250\text{V}$ , $I_D = 16\text{A}$ $R_G = 25\Omega$	--	40	90	ns
$t_r$	Turn-On Rise Time		--	150	310	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	65	140	ns
$t_f$	Turn-Off Fall Time		--	80	170	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 400\text{V}$ , $I_D = 16\text{A}$ $V_{\text{GS}} = 10\text{V}$	--	32	45	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	8.5	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	14	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	--	--	9.2	A	
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	37	A	
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0\text{V}$ , $I_S = 16\text{A}$	--	--	1.4	V
$t_{\text{rr}}$	Reverse Recovery Time	$V_{\text{GS}} = 0\text{V}$ , $I_S = 16\text{A}$ $dI_F/dt = 100\text{A}/\mu\text{s}$	--	490	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		(Note 4)	--	5.0	$\mu\text{C}$

### NOTES:

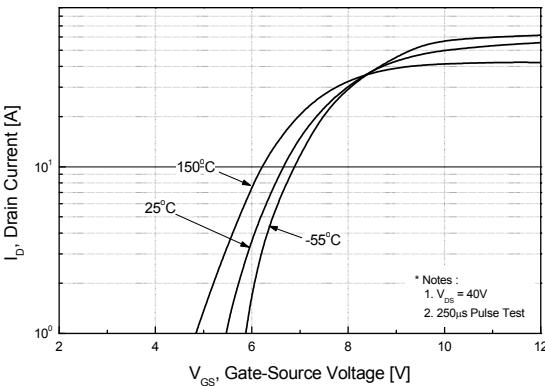
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $L = 5.5\text{mH}$ ,  $I_{AS} = 16\text{A}$ ,  $V_{DD} = 50\text{V}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 16\text{A}$ ,  $dI/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

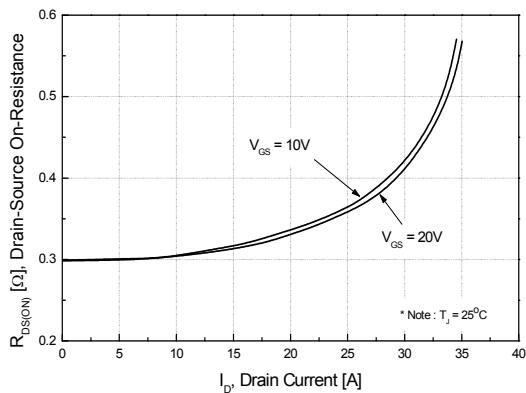
**Figure 1. On-Region Characteristics**



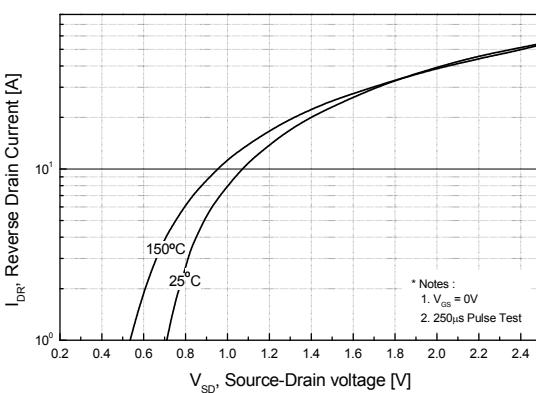
**Figure 2. Transfer Characteristics**



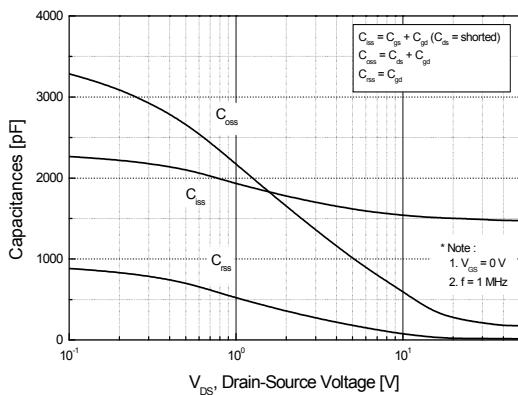
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



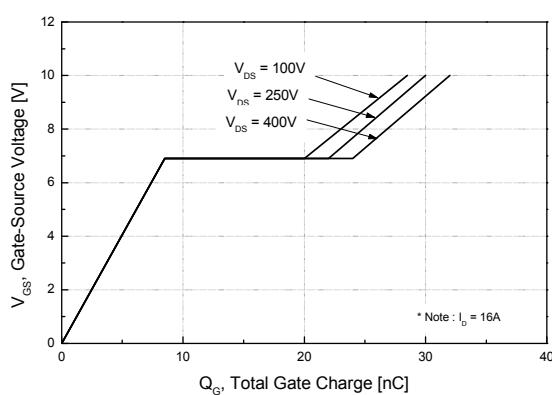
**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**



**Figure 5. Capacitance Characteristics**

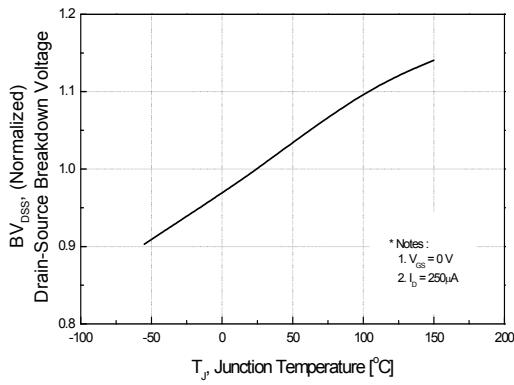


**Figure 6. Gate Charge Characteristics**

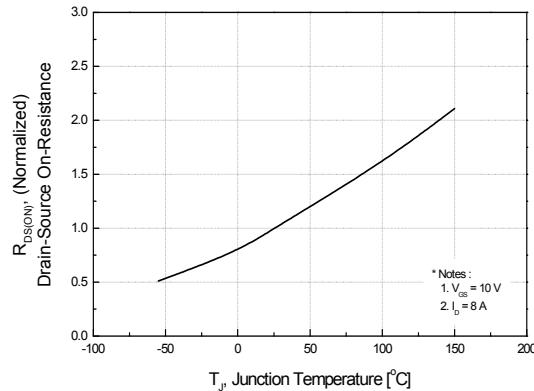


## Typical Performance Characteristics (Continued)

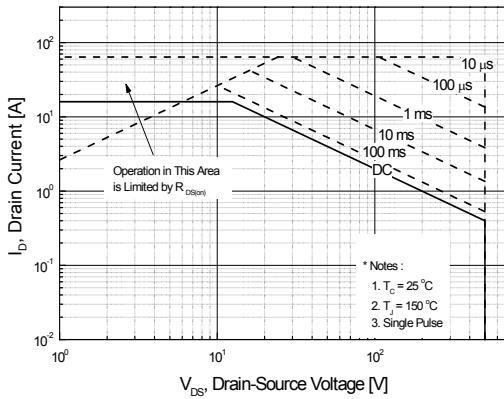
**Figure 7. Breakdown Voltage Variation vs. Temperature**



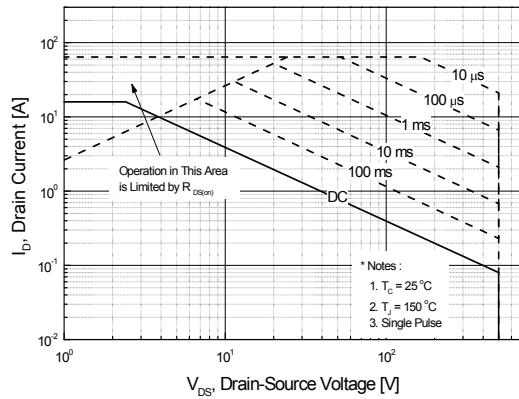
**Figure 8. On-Resistance Variation vs. Temperature**



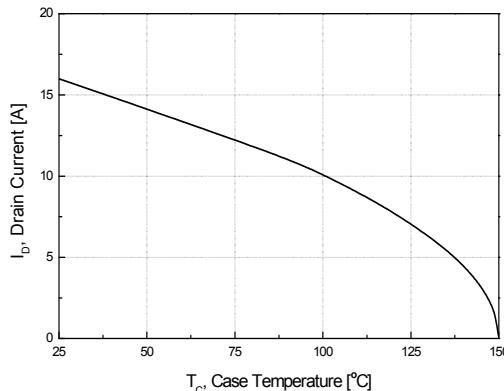
**Figure 9-1. Maximum Safe Operating Area - FDP16N50**



**Figure 9-2. Maximum Safe Operating Area - FDPF16N50**

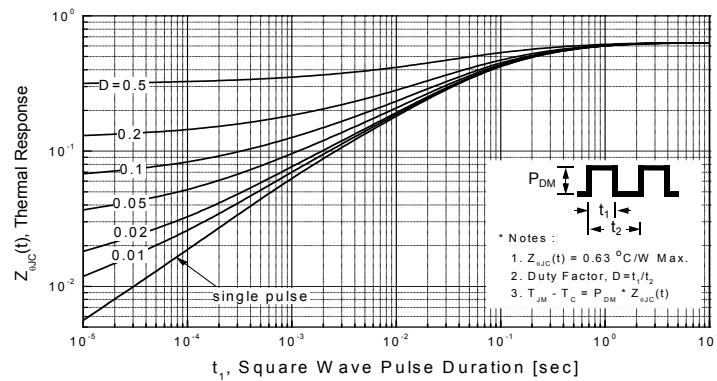


**Figure 10. Maximum Drain Current vs. Case Temperature**

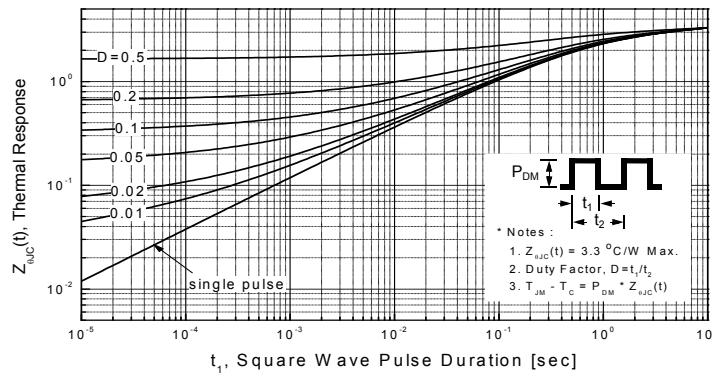


## Typical Performance Characteristics (Continued)

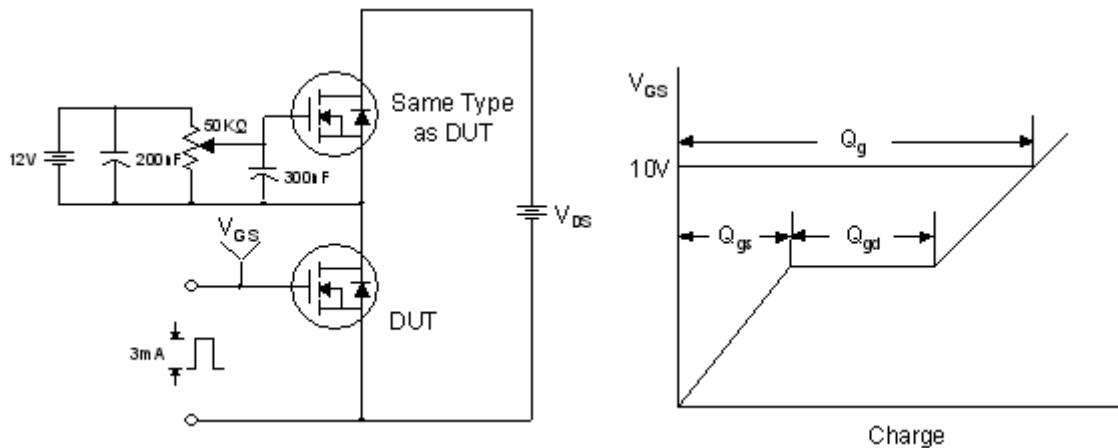
**Figure 11-1. Transient Thermal Response Curve - FDP16N50**



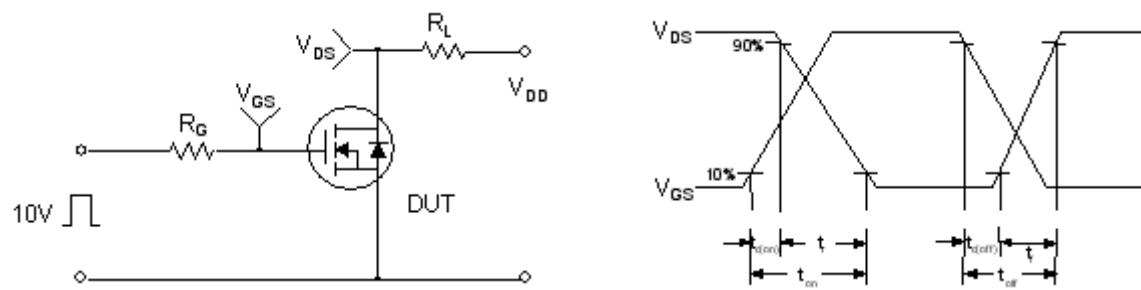
**Figure 11-2. Transient Thermal Response Curve - FDPF16N50**



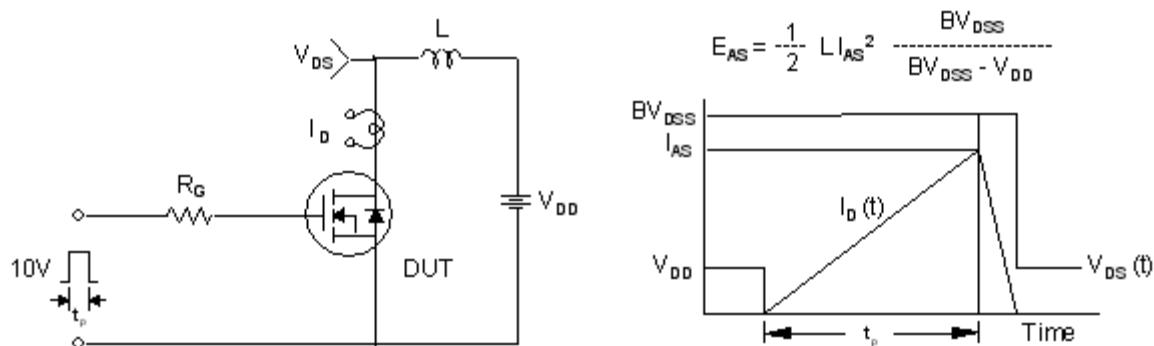
### Gate Charge Test Circuit & Waveform



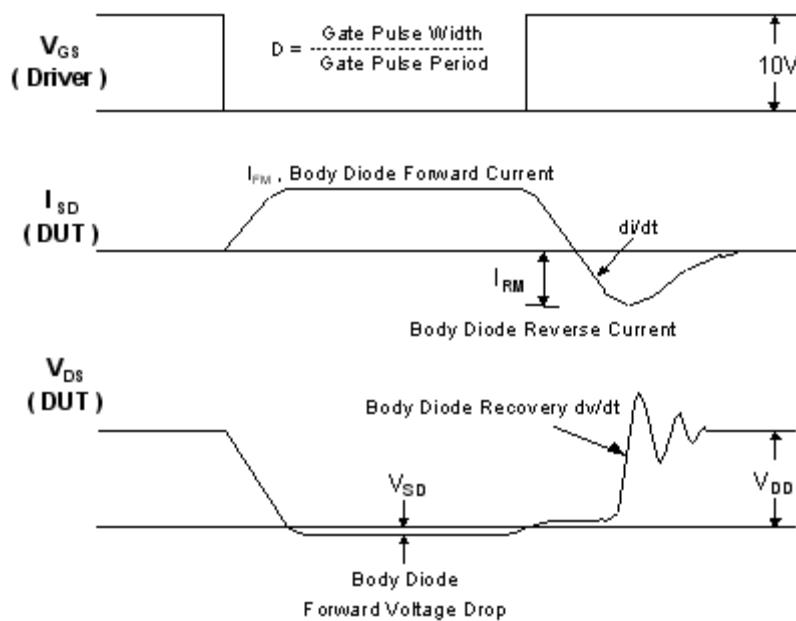
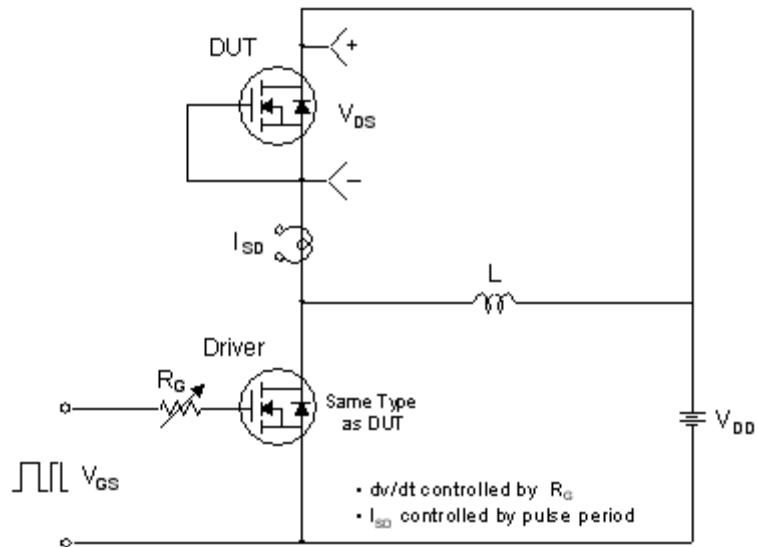
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms

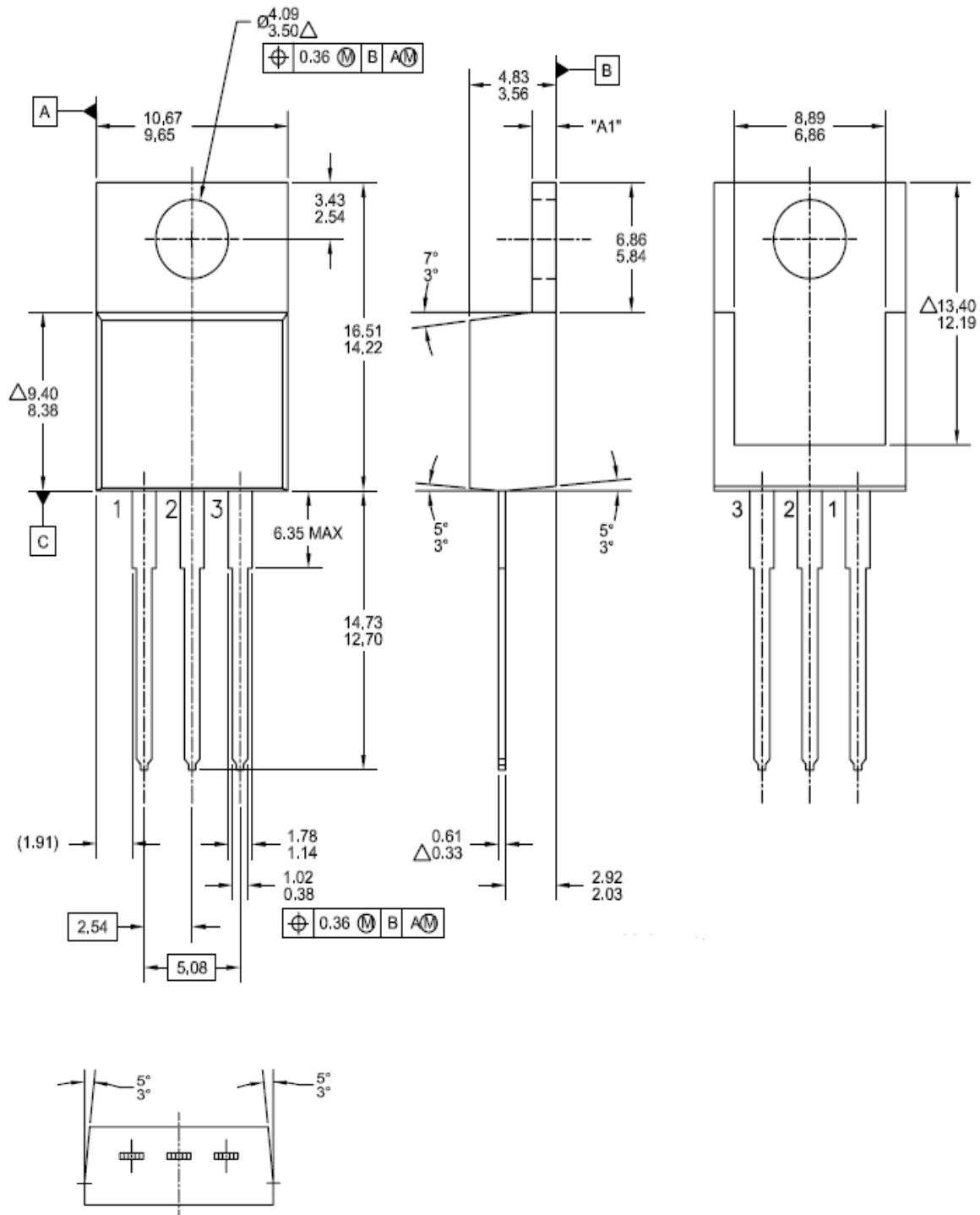


Peak Diode Recovery dv/dt Test Circuit & Waveforms



## Mechanical Dimensions

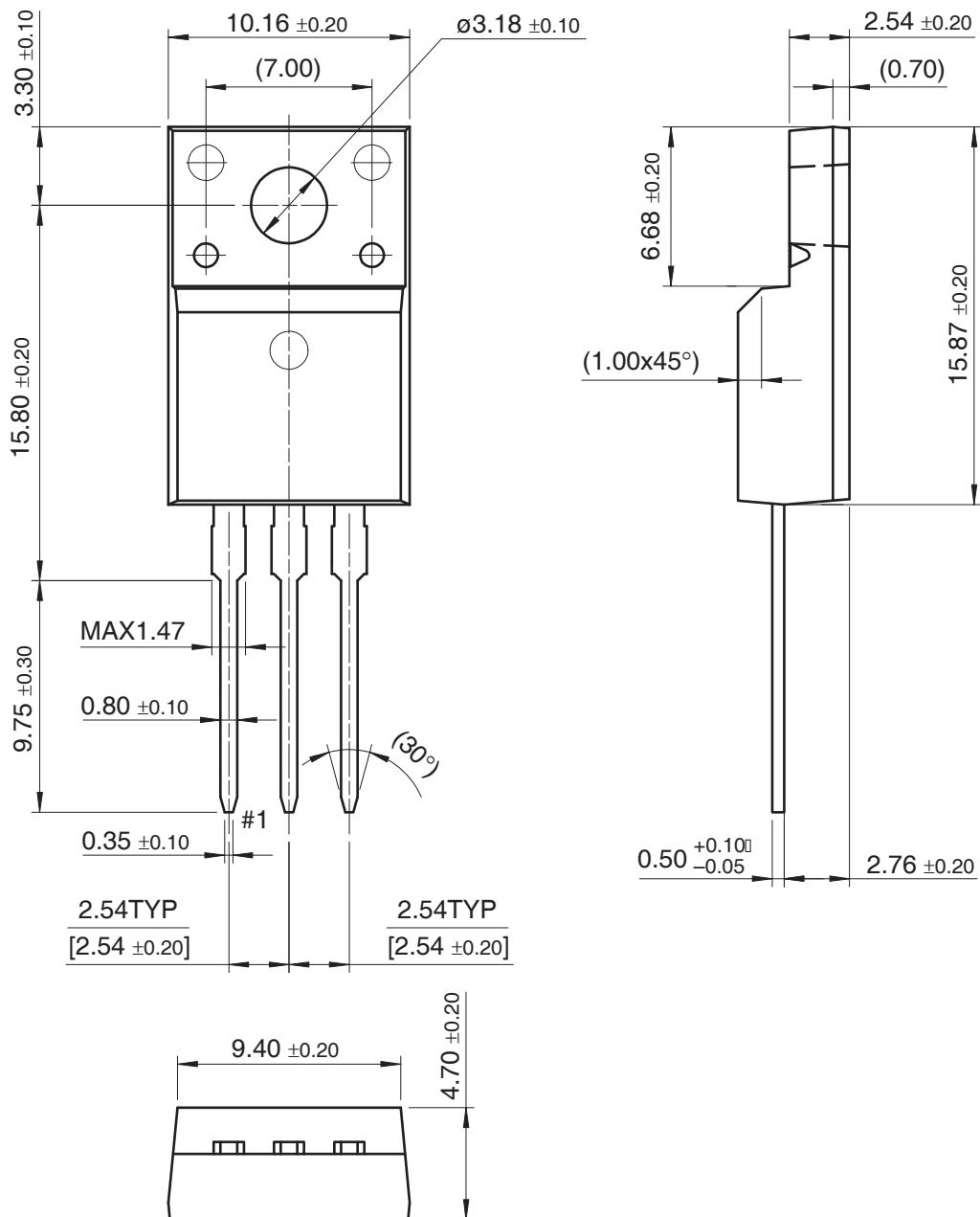
TO - 220



### Dimensions in Millimeters

## Mechanical Dimensions

TO-220F





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Rev. I26



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